

Proceedings **The ATLAS ITk Strip Detector System for the Phase-II LHC Upgrade**

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Abstract: ATLAS[\[1\]](#page--1-0) is currently preparing for the HL-LHC upgrade, with an all-silicon Inner Tracker (ITk) that will replace the current Inner Detector. The ITk will feature a pixel detector surrounded by a strip detector, with the strip system consisting of 4 barrel layers and 12 endcap disks. After successful completion of a large scale prototyping program, final design reviews have been completed in key areas, such as Sensors, Modules, Front-End electronics and ASICs. We present an overview of the Strip System, and highlight the final design choices of sensors, modules and ASICs. We will summarize results achieved during prototyping and the current status of production and pre-production on various detector components, with an emphasis on QA and QC procedures.

Keywords: HL-LHC;ATLAS;ITk;detector upgrades;silicon detectors

1. High-Luminosity Large Hadron Collider (HL-LHC) and the ATLAS Inner Tracker (ITk)

The Large Hadron Collider (LHC) is the most advanced facility in the world for investigating matter at its smallest scale. With a record-holding collision energy of 13.6 TeV, the LHC possesses a unique opportunity to explore questions from the nature of dark matter to the origin of neutrino mass. To observe low-probability phenomena that address these questions and increase the precision of current measurements, the LHC will be upgraded to the High-Luminosity LHC (HL-LHC). The HL-LHC will achieve a peak luminosity of 7.5×10^{34} cm⁻²s⁻¹, corresponding to approximately 200 proton-proton collisions per bunch crossing. This is more than three times the current pileup. Ultimately, the ATLAS detector expects to collect 3000 fb⁻¹ of data during the HL-LHC, an order of magnitude higher than that previously collected.

Radiation damage, limitations from detector occupancy, and bandwidth saturation associated with this luminosity increase will render the current ATLAS Inner Detector inoperable in the HL-LHC. As a result, it will be replaced with the new ATLAS Inner Tracker (ITk) [\[2\]](#page--1-1). ITk is an all-silicon detector that consists of a pixel detector close to the beamline surrounded by a strip detector. It will have better radiation tolerance, increased granularity, a higher (1 MHz) trigger rate, and extended *η* coverage (|*η*| < 4.0).

Figure [1](#page--1-2) shows a rendering of ITk and the layout of detector elements in one quadrant of ITk. The Strip Detector consists of four barrel layers and six endcap disks per forward region. In total, more than 15000 modules consisting of over 65 million channels and 165 $m²$ of silicon will make up the Strip Detector.

2. ITk System

The ITk is composed of silicon detector units called modules glued on carbon fiber local support structures. To create a module, electronics are mounted on silicon sensors. There are two types of local support structures: staves for the barrel region and petals for the endcap regions. An overview of ITk components is given below.

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Figure 1. (**a**) A complete simulation of ITk. (**b**) The layout of ITk detector elements. The pixel detector is shown in red and the strip detector is shown in blue. The horizontal axis is distance along the beamline and the vertical axis is the radial distance from the beamline. [\[2\]](#page-6-0)

2.1. Sensors

ITk silicon strip sensors are AC-coupled strip sensors with n^+ implants in a p-type bulk. A bias voltage depletes the sensor and creates a potential difference. Charged particles then pass through the sensor and create electron-hole pairs which travel according to the potential differencee and are collected as signal. ITk strip sensors are radiation tolerant up to fluences of 1.6×10^{16} neq/ cm² and will experience an expected maximum fluence of 5.4×10^{14} neq/ cm² [\[2\]](#page-6-0).

There are six types of strip sensors in the Strip Detector [\[3\]](#page-6-1). The inner two layers of the barrel region consist of short-strip sensors with 2.4 cm strip length, while the outer two layers consist of long-strip sensors with 4.8 cm strip length. Both of these sensor types have an active area of 9.7×9.7 cm² and a 75.5 μ m strip pitch. The endcap region requires six sensor geometries to create the disk shape of the endcaps, with strip lengths varying from 1.5 to 6 cm and strip pitches from 70 to 80 *µ*m. These lengths are decreased from 12.8 cm in the current ATLAS Semiconductor Tracker, giving the improved resolution necessary in the high occupancy environment of the HL-LHC. All eight sensor geometries are shown in Figure [2.](#page-1-0)

Figure 2. The eight types of sensors in the ITk Strip Detector. The two rectangular sensors in the upper-left make up the barrel region. The remaining six curved geometries are used in the endcap regions [\[4\]](#page-6-2).

2.2. Power boards

Power for front-end electronics and various monitoring and control functionalities are provided by power boards. Power boards receive 11V and output 1.5V to front-end Application Specific Integrated Circuits (ASICs) via an aluminum shielded buck converter called the DC-DC. 11V is also received by the LinPOL, a linear regulator on the power board that steps down this voltage for power board components.

The LinPOL is necessary to immediately supply 1.4V to the Autonomous Monitor Control Chip, a custom ASIC that monitors the module environment (via measurements of voltage, current, and temperature) and controls module electronics. The AMAC is responsible for enabling and disabling the DC-DC and thus controls the powering of front-end ASICs. The LinPOL also supplies 3.3V to the Gallium Nitride FET (GanFET), a transistor that acts as a switch for isolating failed sensors connected to the same high voltage line. Figure [3](#page-2-0) shows a barrel module power board.

Figure 3. A barrel module power board. The DC-DC buck converter (covered by aluminum shield), LinPOL linear regulator, Autonomous Monitor and Control chip, and Gallium Nitride Field Effective Transistor are outlined in green, red, yellow, and blue respectively.

2.3. Hybrids

Front-end electronics are hosted by low-mass PCBs called hybrids. Each hybrid contains 7-12 ATLAS Binary Chips (ABCs), front-end chips with 256 channels that read analog signals from the sensor and provide a binary per strip readout. The amplified, shaped, and discriminated signal is then sent to a Hybrid Controller Chip (HCC) for packaging and shipping out of the module. The HCCs also distribute bunch crossing clock and control signals to ABCs. Each hybrid has 0-2 HCCs—ABCs on hybrids without HCCs send data to connected hybrids with two HCCs. Figure [4](#page-2-1) shows a barrel module hybrid.

Figure 4. A barrel module hybrid. The HCC is outlined in red and one of the ABCs is outlined in blue. Note that each ABC has 256 wire bonds connecting the front-end channels to the sensor's silicon strips.

2.4. Modules

Power boards and hybrids are glued directly onto sensors to form silicon detector units called modules [\[5\]](#page-6-3). Barrel region modules have one power board and either one long-strip sensor and one hybrid or one short-strip sensor and two hybrids (to allow readout of twice as many strips). Endcap region modules also have one power board but can be "split" into two sensors with connected hybrids. The different types of modules are showin in Figure [5.](#page-3-0) Modules are biased up to -500V during detector operation to ensure appropriate end-of-life signal to noise ratios.

2.5. Local support structures

Modules are glued onto lightweight carbon fiber support "cores" to form the units for insertion into the ITk detector, called staves in the barrel and petals in the endcaps (Figure [6\)](#page-3-1). These cores provide mechanical support to modules and are thermally conductive to facilitate cooling via fluid routed through the cores with titanium pipes. In ATLAS, liquid $CO₂$ will be used for cooling. Electrical services are provided to the modules through bus tape made of copper and kapton which forms the top layer of the cores.

Figure 5. (**a**) An exploded view of a barrel region short-strip module. (**b**) The six types of endcap region modules. Power boards are not pictured. HCCs are shown in yellow and ABCs are shown in red. [\[2\]](#page-6-0)

Figure 6. An exploded view of a stave core with a module glued on top. Note the titanium cooling tubes passing through the core and the bus tape at the top of the core [\[2\]](#page-6-0).

The simple geometry of the barrel region permits rectangular staves, each consisting of 14 modules per side. 392 staves will make up the barrel region. Petals, on the other hand, have a wedge shape so that 32 petals with six modules per side can be combined to form the endcap disks. Petal modules have a ± 20 mrad stero angle implemented in the sensor geometry. In contrast, modules must be loaded onto staves with a ± 26 mrad angle with respect to the beamline. ITk will consist of a total of 776 petals and staves.

Each local support structure has and End of Substructure (EoS) card for data transfer and communication outside of the stave or petal. Notably, the EoS card hosts the VTRx, a fiber-optic driver/receiver package that transmits optical data, and the lpGBT, a radiation tolerant ASIC that houses the associated electrical tranceivers. The lpGBT performs serialization, error correction, and synchronous signal distribution for communication with off-detector electronics. An overview of a stave and petal is shown in Figure [7.](#page-3-2)

Figure 7. Local support structures for the ITk Strips subdetector. Petals (top) make up the endcap regions while staves (bottom) make up the barrel regions [\[2\]](#page-6-0).

3. Assembly and testing

3.1. Stave and petal loading

Staves and petals are loaded with modules at various international sites. Staves are loaded at Brookhaven National Laboratory and Rutherford Appleton Laboratory. Petal loading occurs at DESY, Vancouver, Freiburg, and IFIC. During the loading procedure, a glue dispensing robot deposits glue onto the stave in a particular pattern. Modules are then placed within 50 *µ*m accuracy. An XYZ metrology scan is performed after the loading. Loading procedure is relatively uniform across sites, with only slight differences in glue patterns, setups, and metrology procedures.

3.2. Quality Control

ITk components must be extensively tested at every stage of assembly. Hybrids, modules, and staves/petals undergo electrical testing, in which the front-end timing is calibrated, channels are made to have a uniform response, and noise in each channel is characterized [\[6\]](#page-6-4). Modules and staves also undergo IV scans, in which varying bias voltages are applied to the sensor and the leakage current through the sensor is measured, ensuring modules do not exhibit exponentially increasing current (electrical breakdown) before the -500V necessary for detector operation. These electrical tests are performed at least 10 times each at room temperature and at −35◦*C* on modules and staves as part of the thermal cycling procedure. In addition to electrical testing, visual inspections and metrology tests are performed on components throughout assembly.

3.3. Systems Tests

To test the full ITk Strips production chain with final parts and $CO₂$ cooling, barrel and endcap Systems Tests are in development. These tests include the full powering chain, cooling infrastructure, electrical services, safety interlocks, and DAQ systems that will be used in the ATLAS detector. The barrel Systems Test (Figure [8\)](#page-4-0) is located at CERN and will house up to 8 staves, 4 of which are already installed. The endcap Systems Test is located at DESY and hosts up to 12 petals, with one currently installed.

Figure 8. The barrel systems test located at CERN. In this image, three short-strip staves and one long-strip stave have been installed.

3.4. Challenges and mitigation

ITk Strips encountered two major technical challenges during pre-production. The first, dubbed "Cold noise", is excessive noise observed below 0 ◦*C* on modules [\[7\]](#page-6-5). Cold noise for

ten modules measured in equivalent noise charge by sensor channel is shown in Figure [9.](#page-5-0) The source of this noise was determined to be mechanical capacitor vibrations on the power board near the DC-DC. It is believed that a piezoelectric effect induces electrical signals from these vibrations but this mechanism is still under active investigation. Using different glue between module electronics and the sensor has been shown to effectively reduce cold noise, especially for long-strip barrel and endcap modules. Kapton sheets placed as an intermediary layer between the sensor and module electronics, called interposers, are another promising solution to cold noise particularly on short-strip barrel modules.

Figure 9. Noise measurements in equivalent noise charge as a function of front-end channel at −35◦*C* for ten modules [\[7\]](#page-6-5). Note that strips exhibiting cold noise tend to coincide with the glue lines underneath the hybrid that are close to the power board.

During thermal cycling of staves, another issue was identified in which cracks form on the silicon sensor, primarily between the hybrid and power board [\[8\]](#page-6-6). This cracking occurs due to a mismatch of the coefficient of thermal expansion between module electronics, glue, and sensors. During cooling, the hybrids and power board contract more than the sensor, causing curling. Sensors are more constrained when glued to the local support structure, resulting in a maximum stress between the hybrid(s) and power board. Rigorous testing of several cracking remediation strategies is ongoing, and some of them have have proved to be effective in solving the issue.

4. Conclusions and Outlook

ATLAS ITk will deliver similar or better tracking performance than the current ATLAS Inner Detector in the harsh HL-LHC environment. The Strip Detector has undergone extensive protyping and pre-production and rigorous Quality Control procedures have been established. The Strip Detector is almost fully in production, with several critical areas having passed the Production Readiness Reviews. Notably, the three ASICs (AMACs, ABCs, and HCCs) and the majority of sensors are already manufactured. Modules have entered production contingent upon resolution of the cracking problem. All remaining components are expected to enter production in 2025.

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